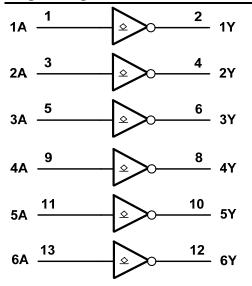


## **Pin Descriptions**

Pin Number	Pin Name	Function
1	1A	Data Input
2	1Y	Data Output
3	2A	Data Input
4	2Y	Data Output
5	3A	Data Input
6	3Y	Data Output
7	GND	Ground
8	4Y	Data Output
9	4A	Data Input
10	5Y	Data Output
11	5A	Data Input
12	6Y	Data Output
13	6A	Data Input
14	V <sub>CC</sub>	Supply Voltage

# Logic Diagram



# **Function Table**

Input	Output
Α	Y
Н	L
L	Z



## **Absolute Maximum Ratings** (Note 4) (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Symbol	Description	Rating	Unit
ESD HBM	Human Body Model ESD Protection	2	KV
ESD CDM	Charged Device Model ESD Protection	1	KV
ESD MM	Machine Model ESD Protection	200	V
V <sub>CC</sub>	Supply Voltage Range	-0.5 to +7.0	V
VI	Input Voltage Range (Note 5)	-0.5 to +7.0	V
I <sub>IK</sub>	Input Clamp Current VI < -0.5V or Vi > V <sub>CC</sub> + 0.5V	±20	mA
$I_{OK}$ Output Clamp Current $V_O < -0.5V$ or $V_O > V_{CC} + 0.5V$		±20	mA
lo	Continuous Output Current - 0.5V < V <sub>O</sub> V <sub>CC</sub> + 0.5V	+/- 25	mA
Icc	Continuous Current Through V <sub>CC</sub>	50	mA
I <sub>GND</sub>	Continuous Current Through GND	-50	mA
T <sub>J</sub> Operating Junction Temperature		-40 to +150	°C
T <sub>STG</sub>	Storage Temperature	-65 to +150	°C
Ртот	Total Power Dissipation	500	mW

Notes: 4. Stresses beyond the absolute maximum may result in immediate failure or reduced reliability. These are stress values and device operation should be within recommend values.

5. Input Voltage cannot exceed  $V_{CC}$  to the extent the Maximum clamp current is exceeded

### Recommended Operating Conditions (Note 6) (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>CC</sub>	Supply Voltage		2.0	6.0	V
VI	Input Voltage		0	Vcc	V
Vo	Output Voltage		0	V <sub>CC</sub>	V
		V <sub>CC</sub> = 2.0V		625	
Δt/ΔV	Δt/ΔV Input transition rise or fall rate	$V_{CC}$ = 4.5V		140	ns/V
		$V_{CC}$ = 6.0V		85	
TA	Operating free-air temperature		-40	+125	°C

Note: 6. Unused inputs should be held at  $V_{CC}$  or Ground.

## Electrical Characteristics (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Symbol Parameter	Test Conditions			C to +85°C	T <sub>A</sub> = -40°C	to +125°C	11	
	Parameter	Parameter Test Conditions	Vcc	Min	Max	Min	Max	Unit
			2.0V	1.5		1.5		
VIH	High-level Input Voltage		4.5V	3.15		3.15		V
	voltage		6.0V	4.2		4.2		
			2.0V		0.5		0.5	
VIL	Low-level input voltage		4.5V		1.35		1.35	V
	voltage		6.0V		1.8		1.8	
		I <sub>OL</sub> = 20μA	2.0V		0.1		0.1	
		I <sub>OL</sub> = 20μA	4.5V		0.1		0.1	
VoL	Low-level Output Voltage	I <sub>OL</sub> = 20µA	6.0V		0.1		0.1	V
	voltage	I <sub>OL</sub> = 4mA	4.5V		0.33		0.44	
		I <sub>OL</sub> = 5.2mA	6.0V		0.33		0.44	
I <sub>OZ</sub>	Z State Leakage Current	V <sub>O</sub> =0 to 6.0V V <sub>I</sub> =GND or 6.0V	6.0V		± 5.0		± 10	μA
II.	Input Current	V <sub>I</sub> =GND to 5.5V	6.0V		± 1		± 1	μA
I <sub>CC</sub>	Supply Current	$V_{I} = GND \text{ or } V_{CC},$ $I_{O}=0$	6.0V		20		40	μA



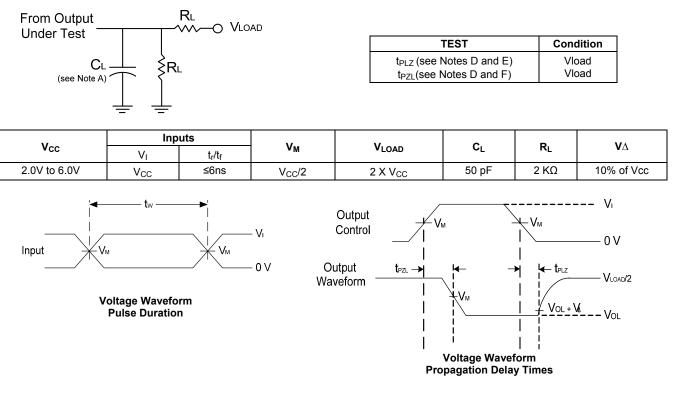
### **Switching Characteristics**

Symbol Parameter	Test	Ma a	-	T <sub>A</sub> = +25°0	)	-40°C to +85°C	-40°C to +125°C	Unit	
Symbol	Parameter	Conditions V <sub>CC</sub>	VCC	Min	Тур	Max	Max	Max	Unit
	$t_{PD}$ Propagation Figure 1 Delay A <sub>N</sub> to Y <sub>N</sub> C <sub>L</sub> = 50 pF	•	2.0V	_	25	90	115	125	
t <sub>PD</sub>			4.5V	_	9	18	23	27	ns
		CL = 50 pF	6.0V	_	7	15	20	23	
	<b>F</b> : 4	Figure 1	2.0V	_	19	75	95	110	
t <sub>t</sub> Transition time	Figure 1 $C_L = 50 \text{ pF}$	4.5V	_	7	15	19	22	ns	
		6.0V	_	6	13	16	19		

#### Operating Characteristics (@T<sub>A</sub> = +25°C, unless otherwise specified.)

	Parameter	Test Conditions	V <sub>CC</sub> = 6V Typ	Unit
C <sub>pd</sub>	Power dissipation capacitance per gate	f = 1 MHz	22	pF
CI	Input Capacitance	$V_{I} = V_{CC} - or GND$	4	pF

#### **Parameter Measurement Information**



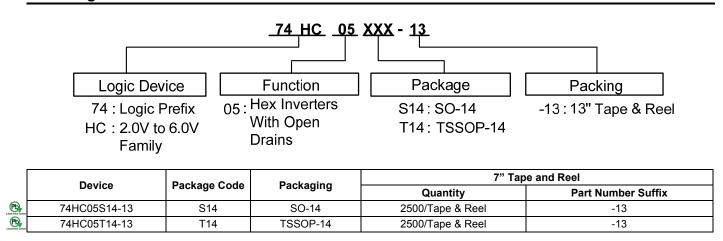
Notes: A. Includes test lead and test apparatus capacitance.

- B. All pulses are supplied at pulse repetition rate  $\leq$  1 MHz.
- C.The inputs are measured one at a time with one transition per measurement.
- D. For the open drain device  $t_{\mathsf{PLZ}}$  and  $t_{\mathsf{PZL}}$  are the same as  $t_{\mathsf{PD.}}$
- E.  $t_{\text{PZL}}$  is measured at V<sub>M</sub>.
- F.  $t_{PLZ}\,$  is measured at V\_OL +V\_{\Delta.}
- D. A Thevenin equivalent load may be used in place of V<sub>CC</sub> X 2 and resistor divider.

#### Figure 1 Load Circuit and Voltage Waveforms

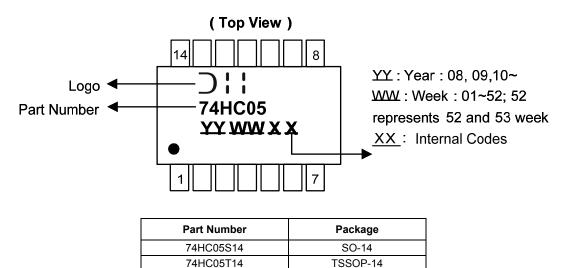


## **Ordering Information**



### **Marking Information**

(1) SO-14, TSSOP-14

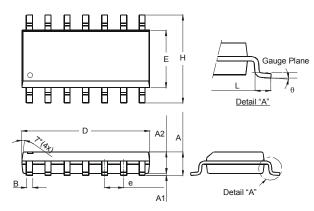




## Package Outline Dimensions (All dimensions in mm.)

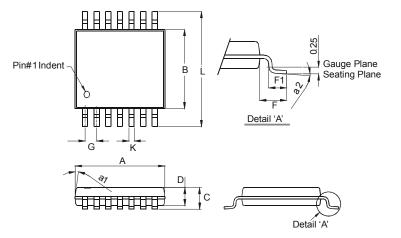
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for latest version.

#### Package Type: SO-14



	SO-14					
Dim	Min	Max				
Α	1.47	1.73				
A1	0.10	0.25				
A2	1.45	Тур				
В	0.33	0.51				
D	8.53	8.74				
E	3.80	3.99				
е	1.27	Тур				
Н	5.80	6.20				
L	0.38	1.27				
θ	0°	8°				
All Di	mensions	s in mm				

#### Package Type: TSSOP-14

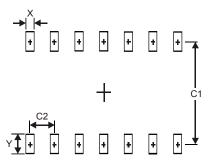


	TSSOP-14					
Dim	Min	Max				
a1	7° (	4X)				
a2	0°	8°				
Α	4.9	5.10				
в	4.30	4.50				
C		1.2				
D	0.8	1.05				
F	1.00	Тур				
F1	0.45	0.75				
G	0.65	Тур				
κ	0.19	0.30				
L	6.40 Typ					
All Dir	nensions	s in mm				

### **Suggested Pad Layout**

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for latest version.

#### Package Type: SO-14



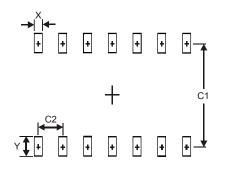
Dimensions	Value (in mm)
Х	0.60
Y	1.50
C1	5.4
C2	1.27



74HC05

### Suggested Pad Layout (cont.)

Package Type: TSSOP-14



Dimensions	Value (in mm)
Х	0.45
Y	1.45
C1	5.9
C2	0.65

#### IMPORTANT NOTICE

DIODES INCORPORATED MAKES NO WARRANTY OF ANY KIND, EXPRESS OR IMPLIED, WITH REGARDS TO THIS DOCUMENT, INCLUDING, BUT NOT LIMITED TO, THE IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A PARTICULAR PURPOSE (AND THEIR EQUIVALENTS UNDER THE LAWS OF ANY JURISDICTION).

Diodes Incorporated and its subsidiaries reserve the right to make modifications, enhancements, improvements, corrections or other changes without further notice to this document and any product described herein. Diodes Incorporated does not assume any liability arising out of the application or use of this document or any product described herein; neither does Diodes Incorporated convey any license under its patent or trademark rights, nor the rights of others. Any Customer or user of this document or products described herein in such applications shall assume all risks of such use and will agree to hold Diodes Incorporated and all the companies whose products are represented on Diodes Incorporated website, harmless against all damages.

Diodes Incorporated does not warrant or accept any liability whatsoever in respect of any products purchased through unauthorized sales channel. Should Customers purchase or use Diodes Incorporated products for any unintended or unauthorized application, Customers shall indemnify and hold Diodes Incorporated and its representatives harmless against all claims, damages, expenses, and attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized application.

Products described herein may be covered by one or more United States, international or foreign patents pending. Product names and markings noted herein may also be covered by one or more United States, international or foreign trademarks.

This document is written in English but may be translated into multiple languages for reference. Only the English version of this document is the final and determinative format released by Diodes Incorporated.

#### LIFE SUPPORT

Diodes Incorporated products are specifically not authorized for use as critical components in life support devices or systems without the express written approval of the Chief Executive Officer of Diodes Incorporated. As used herein:

- A. Life support devices or systems are devices or systems which:
  - 1. are intended to implant into the body, or
  - 2. support or sustain life and whose failure to perform when properly used in accordance with instructions for use provided in the labeling can be reasonably expected to result in significant injury to the user.
- B. A critical component is any component in a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or to affect its safety or effectiveness.

Customers represent that they have all necessary expertise in the safety and regulatory ramifications of their life support devices or systems, and acknowledge and agree that they are solely responsible for all legal, regulatory and safety-related requirements concerning their products and any use of Diodes Incorporated products in such safety-critical, life support devices or systems, notwithstanding any devices- or systems-related information or support that may be provided by Diodes Incorporated. Further, Customers must fully indemnify Diodes Incorporated and its representatives against any damages arising out of the use of Diodes Incorporated products in such safety-critical, life support devices or systems.

Copyright © 2013, Diodes Incorporated

www.diodes.com